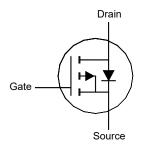
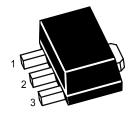
### **P-Channel Enhancement Mode MOSFET**

#### **Features**

· Surface-mounted package





1.Gate 2.Drain 3.Source SOT-89 Plastic Package

### **Applications**

- Portable appliances
- Battery management

### Absolute Maximum Ratings (at Ta = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	-V <sub>DS</sub>	30	V
Gate-Source Voltage	V <sub>GS</sub>	± 20	V
Drain Current	-I <sub>D</sub>	4.2	Α
Peak Drain Current, Pulsed 1)	-I <sub>DM</sub>	20	Α
Power Dissipation <sup>2)</sup>	P <sub>D</sub>	1.25	W
Operating Junction Temperature	Tj	150	°C
Storage Temperature Range	T <sub>stg</sub>	- 55 to + 150	°C

### **Thermal Characteristics**

Parameter	Symbol	Max.	Unit	
Thermal Resistance from Junction to Ambient 2)	Reja	100	°C/W	

<sup>&</sup>lt;sup>1)</sup> Pulse Test: Pulse Width ≤ 100 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$  = 150°C.



 $<sup>^{2)}</sup>$  Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air, t  $\leq$  10 s.

# **SFTP9435U**

## Characteristics at Ta = 25°C unless otherwise specified

Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at -l <sub>D</sub> = 250 μA	-BV <sub>DSS</sub>	30	-	-	V
Drain-Source Leakage Current at -V <sub>DS</sub> = 30 V	-I <sub>DSS</sub>	-	-	1	μΑ
Gate Leakage Current at V <sub>GS</sub> = ± 20 V	I <sub>GSS</sub>	-	-	± 100	nA
Gate-Source Threshold Voltage at $V_{DS} = V_{GS}$ , $-I_D = 250 \mu A$	-V <sub>GS(th)</sub>	1	-	3	V
Drain-Source On-State Resistance at -V <sub>GS</sub> = 10 V, -I <sub>D</sub> = 4 A at -V <sub>GS</sub> = 4.5 V, -I <sub>D</sub> = 2 A	R <sub>DS(on)</sub>	- -	-	50 90	mΩ
DYNAMIC PARAMETERS					
Forward Transconductance at $-V_{DS} = 5 V$ , $-I_D = 4 A$	<b>g</b> fs	-	10	-	S
Gate resistance at $V_{DS} = 0 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	Rg	-	4.8	-	Ω
Input Capacitance at $V_{GS} = 0 \text{ V}$ , $-V_{DS} = 15 \text{ V}$ , $f = 1 \text{ MHz}$	Ciss	-	1195	-	pF
Output Capacitance at $V_{GS} = 0 \text{ V}$ , $-V_{DS} = 15 \text{ V}$ , $f = 1 \text{ MHz}$	Coss	-	125	-	pF
Reverse Transfer Capacitance at $V_{GS} = 0 \text{ V}$ , $-V_{DS} = 15 \text{ V}$ , $f = 1 \text{ MHz}$	Crss	-	94	-	pF
Total Gate Charge at -V <sub>DS</sub> = 15 V, -I <sub>D</sub> = 4 A, -V <sub>GS</sub> = 10 V at -V <sub>DS</sub> = 15 V, -I <sub>D</sub> = 4 A, -V <sub>GS</sub> = 4.5 V	Qg	- -	19.7 9	- -	nC
Gate-Source Charge at - $V_{DS}$ = 15 V, - $I_D$ = 4 A, - $V_{GS}$ = 10 V	Q <sub>gs</sub>	-	4.7	-	nC
Gate-Drain Charge at - $V_{DS}$ = 15 V, - $I_D$ = 4 A, - $V_{GS}$ = 10 V	$Q_{gd}$	-	3	-	nC
Turn-On Delay Time at -V <sub>DS</sub> = 15 V, -V <sub>GS</sub> = 10 V, -I <sub>D</sub> = 4 A, R <sub>g</sub> = 3.3 $\Omega$	t <sub>d(on)</sub>	-	9.3	-	nS
Turn-On Rise Time at -V <sub>DS</sub> = 15 V, -V <sub>GS</sub> = 10 V, -I <sub>D</sub> = 4 A, R <sub>g</sub> = 3.3 $\Omega$	tr	-	31	-	nS
Turn-Off Delay Time at -V <sub>DS</sub> = 15 V, -V <sub>GS</sub> = 10 V, -I <sub>D</sub> = 4 A, R <sub>g</sub> = 3.3 $\Omega$	t <sub>d(off)</sub>	-	14	-	nS
Turn-Off Fall Time at -V <sub>DS</sub> = 15 V, -V <sub>GS</sub> = 10 V, -I <sub>D</sub> = 4 A, R <sub>g</sub> = 3.3 $\Omega$	t <sub>f</sub>	-	2.8	-	nS
Body-Diode PARAMETERS					
Body Diode Voltage at -ls = 1 A, V <sub>GS</sub> = 0 V	-V <sub>SD</sub>	-	-	1.3	V
Body-Diode Continuous Current	-Is	-	-	4.2	Α
Body Diode Reverse Recovery Time at -I <sub>s</sub> = 4 A, di/dt = 100 A / µs	t <sub>rr</sub>	-	9.7	-	nS
Body Diode Reverse Recovery Charge at -I <sub>s</sub> = 4 A, di/dt = 100 A / µs	Q <sub>rr</sub>	-	4	-	nC



#### **Electrical Characteristics Curves**

Fig. 1 Typical Output Characteristics

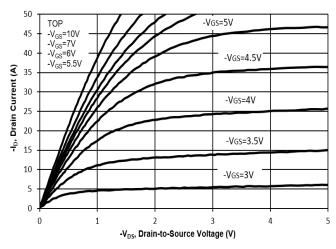


Fig. 2 Typical Transfer Characteristics

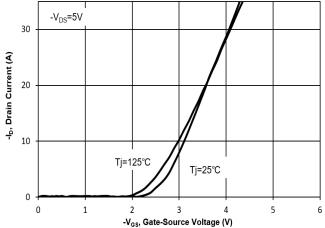


Fig. 3 On-Resistance vs. Drain Current

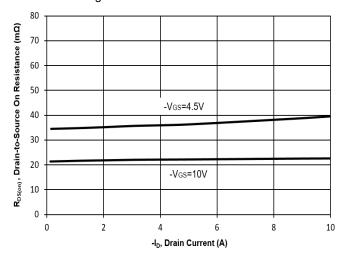


Fig. 4 On-Resistance vs. Gate-Source Voltage

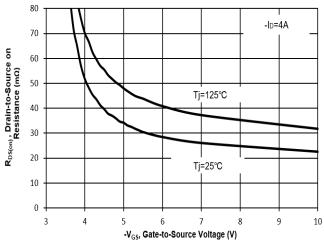


Fig. 5 On-Resistance vs.T<sub>j</sub>

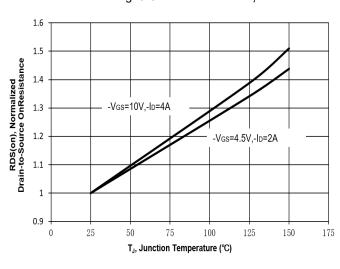
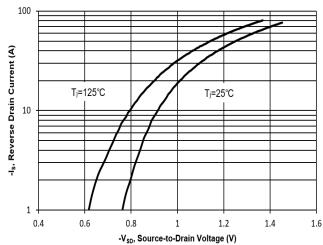


Fig. 6 Typical Body-Diode Forward Characteristics





### **Electrical Characteristics Curves**

Fig. 7 Typical Junction Capacitance

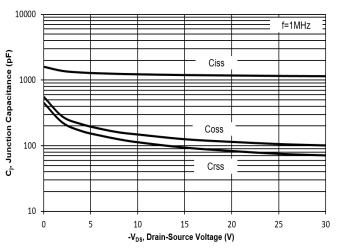


Fig. 8 Drain-Source Leakage Current vs. Tj

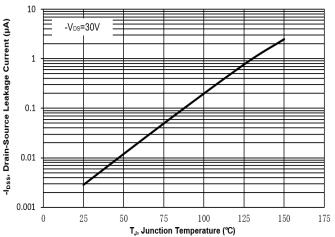


Fig. 9 V<sub>(BR)DSS</sub> vs. Junction Temperature

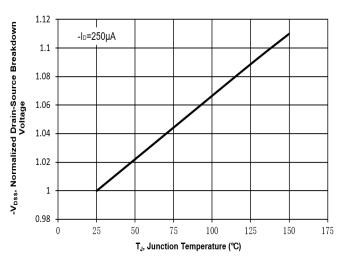


Fig. 10 Gate Threshold Variation vs. T<sub>j</sub>

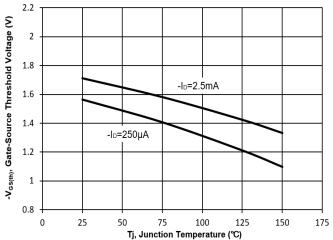
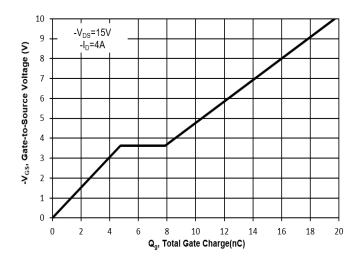
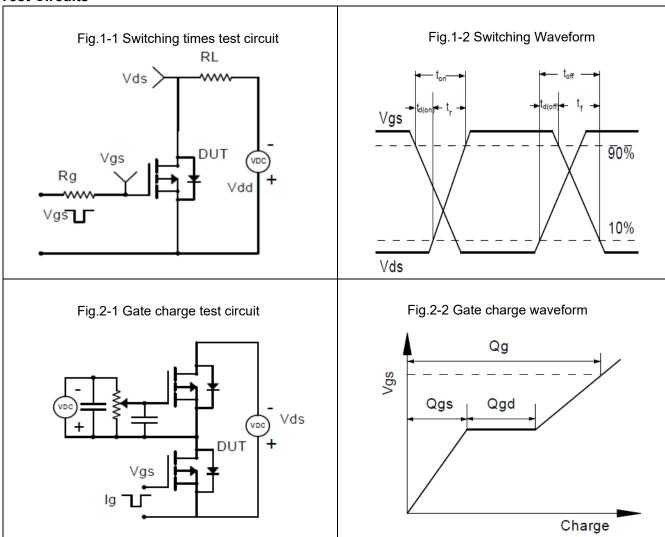


Fig. 11 Gate Charge



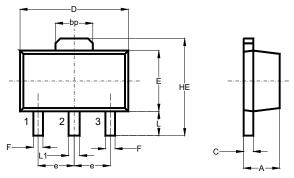


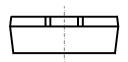
# **Test Circuits**



### Package Outline (Dimensions in mm)

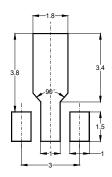
**SOT-89** 





Unit	Α	bp	С	D	Е	F	HE	е	L	L1
mm	1.6	1.60	0.5	4.6	2.6	0.45	4.25	1.5	1.05	0.51
	1.4	1.50	0.3	4.4	2.4	0.35	3.75	typ.	0.95	0.41

#### **Recommended Soldering Footprint**



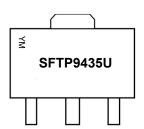
**Packing information** 

	Tape Width	Pitch		Ree	el Size	
Раскаде	Package (mm) mm		inch	mm	inch	Per Reel Packing Quantity
227.00	40	2 2 4		178	7	1,000
SOT-89	12	8 ± 0.1	0.315 ± 0.004	330	13	4,000

### **Marking information**

- " SFTP9435U " = Part No.
- " YM " = Date Code Marking
- " Y " = Year
- " M " = Month

Font type: Arial



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